

UNITED STATE DEPARTMENT OF COMMERCE Pat nt and Trademark Office

Address: COMMISSIONER OF PATENTS AND TRADEMARKS

Washington, D.C. 20231

APPLICATION NO. FILING DATE FIRST NAMED INVENTOR ATTORNEY DOCKET NO. · K 2342-0111P TOYODA ~08/905,971 08/05/97 **EXAMINER** IM62/0701 ZERVIGON, R BIRCH STEWART KOLASCH AND BIRCH P 0 BOX 747 **ART UNIT** PAPER NUMBER FALLS CHURCH VA 22040-0747 1763 DATE MAILED: 07/01/99

Please find below and/or attached an Office communication concerning this application or proceeding.

Commissioner of Patents and Trademarks



OFFICE CON

Office Action Summary

Application No. 08/905,971

Applicant(s)

Kazayuki et al

Examiner

Rudy Zervigon

Group Art Unit 1763

	nudy Zervigon	
Responsive to communication(s) filed on		
☐ This action is FINAL .		
☐ Since this application is in condition for allowance excel in accordance with the practice under <i>Ex parte Quayle</i> ,		n as to the merits is closed
A shortened statutory period for response to this action is is longer, from the mailing date of this communication. Fall application to become abandoned. (35 U.S.C. § 133). Extra 37 CFR 1.136(a).	lure to respond within the period	for response will cause the
Disposition of Claims		
X Claim(s) 1-26	is/are	pending in the application.
Of the above, claim(s)	is/are w	ithdrawn from consideration.
☐ Claim(s)		
☐ Claim(s)		
Claims		
 ☒ See the attached Notice of Draftsperson's Patent Draft	objected to by the Examiner.	disapproved.
Priority under 35 U.S.C. § 119 Acknowledgement is made of a claim for foreign pri All Some* None of the CERTIFIED cop received. received in Application No. (Series Code/Serial received in this national stage application from *Certified copies not received: Acknowledgement is made of a claim for domestic	ies of the priority documents had Number) the International Bureau (PCT for the International Bureau)	ve been _ · Rule 17.2(a)).
Attachment(s) ☑ Notice of References Cited, PTO-892 ☑ Information Disclosure Statement(s), PTO-1449, Paper Interview Summary, PTO-413 ☑ Notice of Draftsperson's Patent Drawing Review, PTO-152	per No(s)	
SEE OFFICE ACTION	ON THE FOLLOWING PAGES	

Art Unit: 1763

DETAILED ACTION

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1-4, 9, 14, 15, 16, 22 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tepman et al (U.S. Pat. 5,186,718) in view of Mikio Takagi (Pub. No. 2-152251). Tepman et al describe a substrate processing apparatus (item 20, Figure 1) where component chambers are each hermetically configured (column 1, lines 59-63) and exhibit the following attributes:
- i. a substrate transfer section embodied by Tepman et al here as item 24, Figure 1 (column 4, line 40)
- ii. a plurality of detachably attached modules embodied here by Tepman et al as processing chambers for processing substrates (items 34, Figure 1; column 4, lines 3-9) and a plurality of modules embodied by Tepman et al as first and second intermediate processing or treatment chambers (items 26, 27, and 28Figure 1) for processing substrates. The implication that Tepman et al provides a plurality of detachably attached modules embodied here by Tepman et al as processing chambers (items 34, Figure 1; column 4, lines 3-7) is supported by the selection of a monolithic design for the main housing (item 22, Figure 1; column 4,

Art Unit: 1763

lines 30-37). If item 22 is monolithic then processing chambers (items 34, Figure 1) must therefore be a plurality of detachably attached modules.

- iii. first substrate transfer means embodied by Tepman et al as item 40 of Figure 1 (column 4, lines 39-46) provided in
- iv. a substrate transfer section (item 24, Figure 1) capable of transferring a substrate to the plurality of modules
- v. a first valve (items 38, figure 1) capable of establishing hermetic (column 1, lines 59-63) isolation between the processing chambers for processing substrates (items 34, Figure 1; column 4, lines 3-9) and a plurality of modules embodied by Tepman et al as first and second intermediate processing or treatment chambers (items 26, 27, and 28Figure 1) when the first valve is closed and allowing a substrate to pass through when opened (column 4, lines 7-9) is a second valve (items 38, figure 1) capable of establishing hermetic (column 1, lines 59-63) isolation between the first and second intermediate processing or treatment chambers (items 26, 27, and 28 Figure 1) and a substrate transfer section embodied by Tepman et al here as item 24, Figure 1 (column 4, line 40) when the second valve is closed and allowing
- vii. a third valve (items 38, figure 1) capable of establishing hermetic (column 1, lines 59-63) isolation between the first and second intermediate processing or treatment chambers (items 26, 27, and 28 Figure 1) and a substrate transfer section embodied by Tepman et al

a substrate to pass through when opened (column 4, lines 7-9)

Art Unit: 1763

here as item 24, Figure 1 (column 4, line 40) when the third valve is closed and allowing a substrate to pass through when opened (column 4, lines 7-9)

- first and second intermediate processing or treatment chambers additionally are provided viii. with second substrate transfer means (item 42, Figure 1; column 4, lines 47-48) capable of transferring a substrate to a processing or treatment chamber.
- all component chambers are each hermetically configured (column 1, lines 59-63) and can ix. be independently reduced in pressure (column 4, line 63 - column 5 line 5). Motivation for such design is additionally provided (column 5, lines 5-14).
- an intermediate chamber (item 24, Figure 1) supporting substrate holding means (item 40, X. Figure 1) positioned closer to the substrate transfer section (items 21, Figure 1) than the second substrate transfer means (item 42, Figure 1,2,3a,3b,4a,4b)

Tepman et al does not expressly describe processing a plurality of substrates. Nor does Tepman et al expressly describe modules piled up separately in a substantially vertical direction.

Mikio Takagi describes a manufacturing system of vertical-type semiconductor (title, JPO abstract). Specifically, Mikio Takagi describes "...a process chamber installed in each stage position of a space positioned in an up-and-down direction..." in order to "..reduce a floor area and to easily install more systems...". Thus the Mikio Takagi reference supports a substrate processing apparatus hermetically configured exhibiting modules piled up separately in a substantially vertical direction. Mikio Takagi

Page 5

Serial Number: 08/905,971

Art Unit: 1763

additionally describes all component chambers each hermetically configured and can be independently reduced in pressure (abstract, "Individual process chambers are evacuated in advance to a prescribed pressure by using individual pumps 3"). Mikio Takagi additionally provides for an elevator capable of vertically moving a first substrate transfer means (items 11, 14; constitution).

It is the examiner's position that a person of ordinary skill in the art, at the time the invention was made, would have found it obvious to modify the Tepman et al substrate processing apparatus by implementing the Mikio Takagi substrate processing apparatus hermetically configured exhibiting modules piled up separately in a substantially vertical direction. Motivation for such design alteration of the Tepman et al substrate processing apparatus is provided by Mikio Takagi. Specifically, "To reduce a floor area and to easily install more systems (..."modules being detachable attached..")" which is centered on reducing the clean room foot print in order to reduce operating costs. Hence, impetus is economical.

Claims 5,6,17,18 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tepman et al (U.S. Pat. 5,186,718) as applied to claims 1-4 above, and further in view of Hideki Lee (U.S. Pat. 5,616,208). Tepman et al do not describe processing substrates under atmospheric pressure through a substrate transfer section. Hideki Lee describes a vacuum processing apparatus including

Art Unit: 1763

a plurality of vacuum processing chambers (column 9, lines 19-34). Specifically, Hideki Lee describes processing substrates serially and under atmospheric pressure (column 10, lines 32-42) through a substrate transfer section (items 20, 21, Figure 8). Additionally, Hideki Lee, as well as Tepman et al (column 5, lines 1-14), describes processing substrates in a substrate processing chamber (items 1, 2, and 3, Figure 8) under reduced pressure (column 9, line 24).

It is the examiner's position that a person of ordinary skill in the art at the time the invention was made would have found it obvious to modify the Tepman et al multichamber processing apparatus whereby substrates are transferred through a *substrate transfer section (items 20, 21, Figure 8)* while sustaining atmospheric pressure as is taught by Hideki Lee. Motivation for processing substrates that are transferred through a *substrate transfer section (items 20, 21, Figure 8)* while sustaining atmospheric pressure during the transfer is centered on selecting where, in the processing of the substrate, the reactant gas will be introduced. Such selection is within the independent pressure control as exhibitted by the references and encompased within the level of ordinary skill in view of the cited references.

4. Claim 7 is rejected under 35 U.S.C. 103(a) as being unpatentable over Tepman et al (U.S. Pat. 5,186,718) as applied to claims 1-4 above, and further in view of Sato Junichi (Pub. No. 04240721). Tepman et al does not describe cassette holding means accommodating a plurality of substrates where the first substrate transfer means is capable of transferring a substrate between the cassette and plurality of modules. According to the JPO abstract, Sato Junichi describes cassette holding means (item 21) accommodating a plurality of substrates (items A) where the first substrate

Page 7

Serial Number: 08/905,971

Art Unit: 1763

transfer means (discussed in constitution) is capable of transferring a substrate between the cassette and plurality of modules (items 26,27,29, and 31).

It is the examiner's position that a person of ordinary skill in the art at the time the invention was made would have found it obvious, in view of Sato Junichi, to modify the Tepman et al apparatus by introducing Sato Junichi 's cassette holding means accommodating a plurality of substrates where the first substrate transfer means is capable of transferring a substrate between the cassette and plurality of modules. Motivation for enhancing the Tepman et al apparatus with Sato Junichi's cassette holding means accommodating a plurality of substrates where the first substrate transfer means is capable of transferring a substrate between the cassette and plurality of modules is drawn from the economic advantage of a higher throughput of wafer substrates.

Claim 8 is rejected under 35 U.S.C. 103(a) as being unpatentable over Tepman et al (U.S. Pat. 5,186,718) as applied to claim 7 above, and further in view of Shunpei Yamazaki (U.S. Pat. 4,582,720). Tepman et al and Sato Junichi do not describe a *first substrate transfer means structure* capable of transferring a wafer cassette. Accordingly, Shunpei Yamazaki provides for *first substrate* transfer means structure capable of transferring a wafer cassette (column 4, lines 48-68; column 5, lines 5-17).

Art Unit: 1763

It is the examiner's position that a person of ordinary skill in the art at the time the invention was made would have found it obvious, in view of Sato Junichi and Shunpei Yamazaki, to modify the Tepman et al apparatus by introducing Shunpei Yamazaki's first substrate transfer means structure capable of transferring a wafer cassette (column 4, lines 48-68; column 5, lines 5-17). Motivation for enhancing the Tepman et al apparatus with Shunpei Yamazaki's first substrate transfer means structure capable of transferring a wafer cassette (column 4, lines 48-68; column 5, lines 5-17) is drawn from the economic advantage of a higher throughput of wafer substrates.

Claims 10-13 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tepman et al (U.S. Pat. 5,186,718) as applied to claim 9 above, and further in view of Shunpei Yamazaki (U.S. Pat. 4,582,720). Tepman et al and Mikio Takagi do not specifically describe a cassette introduction section whose height is different from the height of the cassette holding means. Nor do Tepman et al and Mikio Takagi describe processing a plurality of substrates simultaneously. Accordingly, Shunpei Yamazaki provides a cassette introduction section (item A, Figure 1) whose height is different from the height of the cassette holding means (item 70, Figure 1). Additionally, Shunpei Yamazaki describe processing a plurality of substrates simultaneously laterally arranged side by side (column 4, lines 63-68; column 5, lines 5-17).

It is the examiner's position that a person of ordinary skill in the art at the time the invention was made would have found it obvious, in view of Mikio Takagi and Shunpei Yamazaki, to modify the

Art Unit: 1763

Tepman et al apparatus by introducing Shunpei Yamazaki's cassette introduction section (item A, Figure 1) whose height is different from the height of the cassette holding means (item 70, Figure 1) and by providing means for processing a plurality of substrates simultaneously. Motivation for enhancing the Tepman et al apparatus with Shunpei Yamazaki's cassette introduction section (item A, Figure 1) whose height is different from the height of the cassette holding means (item 70, Figure 1) is drawn from the desire for Shunpei Yamazaki's cassette introduction section (item A, Figure 1) to fit the cassette holding means (item 70, Figure 1) when introduced from an exterior position relative to chamber A. Additional motivation for Shunpei Yamazaki's means for processing a plurality of substrates simultaneously is drawn from the motivation presented in the rejection of claim 8.

Claim 19 is rejected under 35 U.S.C. 103(a) as being unpatentable over Tepman et al (U.S. Pat. 5,186,718) as applied to claims 1-4, 9, 14, 15, 16 above, and further in view of Shunpei Yamazaki (U.S. Pat. 4,582,720). Tepman et al describe an intermediate chamber (item 24, Figure 1) supporting substrate holding means (item 40, Figure 1) positioned closer to the substrate transfer section (items 21, Figure 1) than the second substrate transfer means (item 42, Figure 1,2,3a,3b,4a,4b). However, Tepman et al does not specifically describe an intermediate chamber supporting heat-resistant substrate holding means positioned closer to the substrate transfer section than the second substrate transfer means. Because the Tepman et al apparatus plasma processes the substrate in later chambers (items 34, Figure 1), this may imply that there is no

Art Unit: 1763

heat resistance imparted to the intermediate chamber substrate holding means. The structural characteristics of Shunpei Yamazaki's plasma assisted chemical vapor deposition apparatus (column 2, lines 13-21) is in many respects identical to the presently claimed apparatus. The primary difference between the presently claimed invention at that of Shunpei Yamazaki's plasma assisted chemical vapor deposition apparatus is the orientation of the device itself. The presently claimed invention has its long axis (processing direction vector) parallel to the gravity vector while the long axis (processing direction vector) of the Shunpei Yamazak apparatus is perpendicular to the gravity vector. Specifically, Shunpei Yamazak describes a substrate transfer section (item A, Figure 1), an intermediate chamber (item B, Figure 1), and a final processing chamber (item C, Figure 1). An intermediate chamber (item B, Figure 1), supports heat-resistant substrate holding means (item 70, Figure 1) used in the intermediate processing chamber under a heated plasma process (column 5, lines 17-25; lines 55-59).

It is the examiner's position that a person of ordinary skill in the art at the time the invention was made would have found it obvious to enhance the Tepman et al intermediate chamber (item 24, Figure 1) supporting substrate holding means (item 40, Figure 1) positioned closer to the substrate transfer section (items 21, Figure 1) than the second substrate transfer means (item 42, Figure 1,2,3a,3b,4a,4b) by employing heat-resistance as taught by Shunpei Yamazaki's plasma assisted chemical vapor deposition apparatus. Motivation for employing heat resistance to the

Page 11

Serial Number: 08/905,971

Art Unit: 1763

substrate holding means (item 40, Figure 1) is drawn from the fact that plasma generating apparatus

commonly operate at elevated temperatures.

Claims 20.21 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tepman et al 8.

as applied to claims 1-4, 9, 14, 15, 16 above, and further in view of Shunpei Yamazaki. Tepman et

al and Mikio Takagi do not describe a first substrate transfer means structure capable of transferring

a wafer cassette. Accordingly, Shunpei Yamazaki provides for first substrate transfer means

structure capable of transferring a wafer cassette (column 4, lines 48-68; column 5, lines 5-17) to

a plurality of modules (items A,B,C, Figure 1). Additionally, Shunpei Yamazaki describes first

substrate transfer means structure (carrier rod) provided with a structure capable of transferring

a wafer cassette (column 5, lines 8-11).

It is the examiner's position that a person of ordinary skill in the art at the time the invention was

made would have found it obvious, in view of Mikio Takagi and Shunpei Yamazaki, to modify the

Tepman et al apparatus by introducing Shunpei Yamazaki's first substrate transfer means structure

capable of transferring a wafer cassette (column 4, lines 48-68; column 5, lines 5-17). Motivation

for enhancing the Tepman et al apparatus with Shunpei Yamazaki's first substrate transfer means

structure capable of transferring a wafer cassette (column 4, lines 48-68; column 5, lines 5-17) is

drawn from the economic advantage of a higher throughput of wafer substrates.

Art Unit: 1763

9. Claim rejected under 35 U.S.C. 103(a) as being unpatentable over as applied to claim above,

and further in view of.

10. Claims 23, 24, 25 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tepman

et al (U.S. Pat. 5,186,718) as applied to claims 1-4, 9, 14, 15, 16, 22 above, and further in view of

Shunpei Yamazaki (U.S. Pat. 4,582,720). Tepman et al and Mikio Takagi do not specifically describe

a cassette introduction section whose height is different from the height of the cassette holding

means. Nor do Tepman et al and Mikio Takagi describe processing a plurality of substrates

simultaneously. Accordingly, Shunpei Yamazaki provides a cassette introduction section (item A,

Figure 1) whose height is different from the height of the cassette holding means (item 70, Figure 1).

Additionally, Shunpei Yamazaki describe processing a plurality of substrates simultaneously

laterally arranged side by side (column 4, lines 63-68; column 5, lines 5-17) in a plasma assisted

chemical vapor deposition apparatus (column 2, lines 13-21).

It is the examiner's position that a person of ordinary skill in the art at the time the invention was

made would have found it obvious, in view of Mikio Takagi and Shunpei Yamazaki, to modify the

Tepman et al apparatus by introducing Shunpei Yamazaki's cassette introduction section (item A,

Figure 1) whose height is different from the height of the cassette holding means (item 70, Figure 1)

and by providing means for processing a plurality of substrates simultaneously. Motivation for

enhancing the Tepman et al apparatus with Shunpei Yamazaki's cassette introduction section (item

A, Figure 1) whose height is different from the height of the cassette holding means (item 70,

Art Unit: 1763

Figure 1) is drawn from the desire for Shunpei Yamazaki's cassette introduction section (item A,

Page 13

Figure 1) to fit the cassette holding means (item 70, Figure 1) when introduced from an exterior

position relative to chamber A. Additional motivation for Shunpei Yamazaki's means for processing

a plurality of substrates simultaneously is drawn from the motivation presented in the rejection of

claim 8.

Conclusion

The prior art made of record and not relied upon is considered pertinent to 11.

applicant's disclosure. U.S. Pat. No.:

4,666,734

5,773,088

4,405,435

4,717,461

Any inquiry concerning this communication or earlier communications from the examiner 12.

should be directed to Examiner Rudy Zervigon whose telephone number is (703) 305-1351. The

examiner can normally be reached on a Monday through Friday schedule from 8am until 5pm. The

official AF fax phone number for the 1763 art unit is (703) 305-3599. Any Inquiry of a general nature

Art Unit: 1763

or relating to the status of this application or proceeding should be directed to the Chemical and Materials Engineering art unit receptionist at (703) 308-0661.

Bruce Breneman Supervisory Patent Examiner Technology Center 1700

Rudy Zervigon - RZ

June 27, 1999